

Tablet Device

Solution Proposal by Toshiba



R23







Toshiba Electronic Devices & Storage Corporation provides comprehensive device solutions to customers developing new products by applying its thorough understanding of the systems acquired through the analysis of basic product designs.





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Tablet DeviceOverall block diagram



Tablet Device Details of power supply unit

System power circuit

Method using power controller



* Click on the blue circled numbers above to view detailed descriptions.

Criteria for device selection

- TVS diodes are suitable for ESD protection of power line.
- MOSFETs with low on-resistance are suitable for the control of USB and battery powered supply circuits.
- Small package products contribute to the reduction of circuit board area.

Proposal from Toshiba

Prevent circuit malfunctions by absorbing static electricity from external terminals TVS diode

2

6

- Realize the set with low power consumption by low on-resistance
 Small signal MOSFET
- Built-in protection function against short circuit, over current, over voltage, etc.
 Electronic fuse (eFuse IC)
- Small package and built-in over voltage protection function
- N-ch MOSFET gate driver IC
- Low on-resistance and small package N-ch common drain MOSFET

Tablet DeviceDetail of audio unit

Audio unit circuit



Criteria for device selection

- TVS diodes are suitable for ESD protection of signal line.
- Small package products contribute to the reduction of circuit board area.

Proposal from Toshiba

 Prevent circuit malfunctions by absorbing static electricity from external terminals TVS diode

* Click on the blue circled numbers above to view detailed descriptions.

Tablet DeviceDetails of touch sensor unit

Touch sensor circuit

Optical type



Touch sensor circuit

Capacitive type



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Criteria for device selection

- TVS diodes are suitable for ESD protection of signal line.
- Small package products contribute to the reduction of circuit board area.

Proposal from Toshiba

 Prevent circuit malfunctions by absorbing static electricity from external terminals TVS diode

Tablet Device Detail of display unit

Display unit circuit



* Click on the blue circled numbers above to view detailed descriptions.

Criteria for device selection

- TVS diodes are suitable for ESD protection of signal line.
- By using a Schottky barrier diode with low V_F and low I_R , the power consumption of the set can be reduced.
- Small package products contribute to the reduction of circuit board area.
- By using interface bridge, display and camera components can be selected without any concern for interface standards.

Proposal from Toshiba

- Prevent circuit malfunctions by absorbing static electricity from external terminals TVS diode
- High speed, low loss Schottky barrier diode
- Supply the power with low noise Small surface mount LDO regulator
- Eliminate differences between interfaces Interface bridge 5

Tablet DeviceDetail of camera unit

Camera unit circuit



* Click on the blue circled numbers above to view detailed descriptions.

Criteria for device selection

- PSRR (Power Supply Rejection Ratio) of LDO regulator is an important parameter for camera modules.
- TVS diodes are suitable for ESD protection of signal line.
- Small package products contribute to the reduction of circuit board area.
- By using interface bridge, display and camera components can be selected without any concern for interface standards.

Proposal from Toshiba

- Prevent circuit malfunctions by absorbing static electricity from external terminals TVS diode
- Supply the power with low noise
 - Small surface mount LDO regulator
- Eliminate differences between interfaces
 Interface bridge

Tablet DeviceDetail of wireless unit

Wireless communication circuit



* Click on the blue circled numbers above to view detailed descriptions.

Criteria for device selection

- Small package products contribute to the reduction of circuit board area.
- A small TVS diode with low C_t is suitable for ESD protection without attenuating the antenna signal.
- LDO regulator that can supply large current is suitable for the wireless module.

Proposal from Toshiba

- Prevent circuit malfunctions by absorbing static electricity from external terminals TVS diode
- Supply the power with low noise Small surface mount LDO regulator



Tablet Device Detail of over temperature monitoring unit

Over temperature monitoring circuit



Criteria for device selection

- Over temperature monitoring is required at multiple points on the circuit board such as MOSFET, PMIC and Processor.
- Low power dissipation of set can be realized by using the over temperature detection IC with low current consumption.
- Small package products contribute to the reduction of circuit board area.

Proposal from Toshiba

 Monitor temperature at multiple points with small package and low current consumption
 Over temperature detection IC

(ThermoflaggerTM)



* Click on the blue circled numbers above to view detailed descriptions.

Recommended Devices

Device solutions to address customer needs

As described above, in the design of tablet device, "Miniaturization of circuit boards", "Low power consumption of set" and "Robust operation" are important factors. Toshiba's proposals are based on these three solution perspectives.



Device solutions to address customer needs





High Small size efficiency Noise packages immunity Low loss

Value provided

Absorbs static electricity from external terminals, prevents circuit malfunction and protects devices.

Improved ESD pulse absorption

Improved ESD absorption compared to our conventional products. (50 % reduction in operating resistance) For some products, both low operating resistance and low capacitance are realized and ensures high signal protection performance and signal quality.

Suppress ESD energy by low clamp voltage

Protect the connected circuits and devices using proprietary technology.



Suitable for high density mounting

A variety of small packages are available.







Suitable for paths with both polar signals such as logic signals. There are lineups of 1in1, as audio signals 2in1, 4in1, 5in1, 7in1.

Lineup				
Part number	DF2B7ASL	DF2B5M4ASL	DF2B6M4ASL	DF2B6M4BSL
Package	SL2	SL2	SL2	SL2
V _{ESD} [kV]	±30	±16	±15	±8
V _{RWM} (Max) [V]	5.5	3.6	5.5	5.5
C _t (Typ.) [pF]	8.5	0.15	0.15	0.12
R _{DYN} (Typ.) [Ω]	0.2	0.7	0.7	1.05

(Note) This product is designed for ESD protection purpose and cannot be used for purposes other than ESD protection.

Unidirectional



Suitable for power management and contributes to miniaturization.

Low voltage operation

Operates down to $|V_{GS}| = 4.5 V$

Low on-resistance

By reducing on-resistance between the drain and source, heat generation and power consumption can be kept low.



Small package

Small size packages High

efficiency

Low loss

Noise

mmunity

Sealed in SOT-1220 (2.0 x 2.0 mm) package.

Internal circuit SSM6K513NU



Lineup					
Part numb	ber	SSM6K513NU	SSM6N55NU	SSM6J507NU	
Package		UDFN6B (SOT-1220)	UDFN6 (SOT-1118)	UDFN6B (SOT-1220)	
Polarity		N-ch	N-ch x 2	P-ch	
V _{DSS} [V]		30	30	-30	
I _D [A]		15	4	-10	
$R_{DS(ON)} [m\Omega]$ @ $ V_{GS} = 4.5 V$	Тур.	8.0	48	19	
	Max	12	64	28	



Small size packages Low loss

Value provided

Can be applied to various applications which require high speed and low loss. And contribute to miniaturization.



For fast switching applications.



Small package

Small surface mount packages for high density assembly: US2H: 2.5 x 1.4 x 0.6 mm CST2: 1.0 x 0.6 x 0.38 mm

Lineup		
Part number	CUHS20F40	CTS05F40
Package	US2H	CST2
I _O [A]	2.0	0.5
V _R [V]	40	40
V _F (Typ.) [V]	0.39 @I _F = 1.0 A	0.74 @I _F = 0.5 A
I _R (Max) [μΑ] @V _R = 40 V	60	15

◆Return to Block Diagram TOP

CUHS20F40 Characteristics Curves







Wide lineup from general purpose type to small package type are provided. Contribute to realize a stable power supply not affected by fluctuation of battery.

Low dropout voltage

The originally developed latest process significantly improved the dropout voltage characteristics.



High PSRR Low output noise voltage

Many product series that realize both high PSRR (Power Supply Rejection Ratio) and low output noise voltage characteristics are provided. They are suitable for stable power supply for analog circuit.



Low current consumption

0.34 μ A of I_{B(ON)} is realized by utilizing CMOS process and unique circuit technology. (TCR3U Series)

Low dropout voltage



Rich package lineup



Part number	TCR15AG	TCR13AG	TCR8BM	TCR5BM	TCR5RG	TCR3RM	TCR3U	TCR2L	TAR5	
Fait number	Series	Series	Series	Series	Series	Series	Series	Series	Series	
Features	Low dropout voltage High PSRR		High PSRR Low noise Low current consumption		Low current consumption		15 V Input voltage Bipolar type			
I _{OUT} (Max) [A]	1.5	1.3	0.8	0.8 0.5		5 0.3			0.2	
PSRR (Typ.) [dB] @f = 1 kHz	95	90	98	98	100	100	70	-	70	
I _B (Typ.) [μΑ]	25	56	20	19	7	7	0.34	1	170	

Eliminating the interface gap between host and display/camera allows more options of component selection.

Wider component selection

Conversion of the interface allows shared procurement with other products as well as adoption of less inexpensive parts.

Camera

Noise immunity

Converting parallel communication to serial improves noise immunity and suppresses noise generation to the surroundings.



Less cabling

Converting from parallel communication to serial reduces total number of wires and the risks of wire breakage.

Display interface



rocesso

Bridge

Lineup						
Part number	TC358775XBG	TC358767AXBG	TC358860XBG	TC358746AXBG		
Package	BGA64	BGA81	BGA65	BGA72		
Input	MIPI [®] DSI [®] 1.01	(1) MIPI [®] DSI [®] 1.01 (2) MIPI [®] DPI SM 2.0	VESA Embedded DisplayPort™ (eDP)	(1) MIPI® CSI-2® (2) Parallel 24bit		
Output	LVDS Dual Link (5 pairs / link)	VESA DisplayPort™ 1.1a	MIPI [®] DSI [®] 1.02	(1) Parallel 24bit (2) MIPI [®] CSI-2 [®]		



Small size packages Low loss High fficiency Low loss

Value provided

Electronic fuse (eFuse IC) can be used repeatedly to protect circuits from abnormal conditions such as overcurrent and overvoltage.

Can be used repeatedly

When overcurrent flows through the electronic fuse (eFuse IC), the internal detection circuit operates and switches off the internal MOSFET. It is not destroyed by a single overcurrent and can be used repeatedly.



Toshiba's eFuse ICs are certified to the international safety standard IEC 62368-1 (G9: Integrated circuit (IC) current limiters) and contribute to robust protection and simplification of circuit design.



Various protection functions

TCKE8 Series: Short-circuit protection, overcurrent protection, overcurrent clamp function, overvoltage clamp function, thermal shut down, inrush current suppression, backflow prevention (optional), etc.

TCKE7 Series: Short-circuit protection, overcurrent protection, overvoltage protection, thermal shut down, FLAG signal output, backflow prevention (built-in), etc.

Reference circuit example of TCKE8 Series

Reference circuit example of TCKE7 Series



Lineup				
Part number	TCKE800NA/NL	TCKE805NA/NL	TCKE812NA/NL	TCKE712BNL
Package	WSON10B 3.0 x 3.0 x 0.75 mi	m	www.min	WSON10 3.0 x 3.0 x 0.75 mm
V _{IN} [V]		4.4 to 13.2		
R _{on} (Typ.) [mΩ]		53		
Return function	N NL: Latch	Latch type (external signal control)		
V _{OVC} (Typ.) [V]	-	6.04	15.1	Adjustable





It is N-ch MOSFET gate driver IC with OVP [Note 1] function. It contributes to reduction of power consumption and miniaturization of load switch circuit.

Three types of N-ch MOSFET can be driven

The following types of MOSFET can be driven: TCK40xG: Single high side connection Common source connection TCK42xG: Single high side connection Common drain connection



Wide operating voltage range and various OVLO [Note 2]

threshold voltage

Operating voltage V_{opr}: 2.7 to 28 V Maximum input voltage: 40 V $V_{IN OVLO}$ [Note 3] lineups suitable for 5 to 24V power supply line.

> [Note 2] OVLO: Over Voltage Lock Out [Note 3] V_{IN OVLO}: V_{IN} OVLO threshold

[Note 1] OVP: Over Voltage Protection



Small packages

It contributes to reduction of the mounting area and miniaturization of the circuit board:

WCSP6E: 1.2 x 0.8 mm, t: 0.55 mm WCSP6G: 1.2 x 0.8 mm, t: 0.35 mm

Circuit example of TCK42xG with N-ch common drain connection MOSFET



Lineup					
Part number	V _{IN_OVLO} Min / Max [V]	V _{GS} Typ. / Max [V]	N-ch MOSFET type can be driven	Packa	ge
TCK401G	Over 28	Max 10	Single high side	WCSP6E	
TCK402G	Over 20	$(V_{IN} \ge 12 V)$	Common Source		
TCK420G	26.50 / 28.50	10 / 11			
TCK421G	22.34 / 24.05	10/11			
TCK422G	13.61 / 14.91	(V _{IN} 2 5 V)	Single high side	WCCDCC	
TCK423G	13.61 / 14.91		Common Drain	WCSP6G	
TCK424G	10.35 / 11.47	5.6 / 6.3			
TCK425G	5.76 / 6.87				





TCTH series can detect temperature rise at multiple points on the circuit board.

Temperature rise can be detected at multiple points

TCTH series detect an increase in resistance during over temperature by supplying a constant current (1 μ A or 10 μ A) to PTC (Positive Temperature Coefficient) thermistors. Multiple PTC thermistors connected in series enable to detect over temperature at multiple points on the circuit board.





Low current consumption and small package

TCTH01 series has $I_{DD} = 1.8 \ \mu A$ (Typ.) and TCTH02 series has $I_{DD} = 11.3 \ \mu A$ (Typ.). These packages are small size ESV type.

Lineup					
Part number	TCTH011AE/BE	TCTH012AE/BE	TCTH021AE/BE	TCTH022AE/BE	
Package	ESV 1.6 x 1.6 x 0.55 mm				
V _{DD} [V]	1.7 to 5.5				
Ι _{DD} (Typ.) [μΑ]	1.8 11.3			1.3	
PTCO Output current (Typ.) [µA]	1	1	10	10	
Abnormal latch function	-	Yes	-	Yes	
Output circuit type	AE: push pull, BE: open drain				





This is low on-resistance MOSFET with small and thin package. It contributes to suppressing heat generation during charging and discharging, as well as to reducing the size of set.

Low on-resistance

Low on-resistance is achieved by applying a low resistance diffusion process. This contributes to suppression of heat generation.

Small and thin package

While in a dual configuration, it is a small and thin chipLGA package products. This contributes to miniaturization of set.



Low gate-source leakage current

Low gate-source leakage current characteristics enable low standby power and contribute to long term operation of battery used sets.

Examples of common drain MOSFET application

Power multiplexer



Li-ion battery protection circuit



Lineup Part number SSM14N956L SSM10N954L SSM6N951L SSM10N961L Package TCSPED-302701 TCSPAC-153001 TCSP6A-172101 TCSPAG-341501 Source-source voltage V_{SSS} [V] 12 30 Gate-source voltage V_{GSS} [V] ±8 ±20 Source current (DC) I_{s} [A] 20.0 13.5 8.0 14.0 $R_{SS(ON)}$ (Typ.) [m Ω] @V_{GS} = 3.8 V 1.1 2.2 4.6 - $R_{SS(ON)}$ (Typ.) [m Ω] @V_{GS} = 10 V 99

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